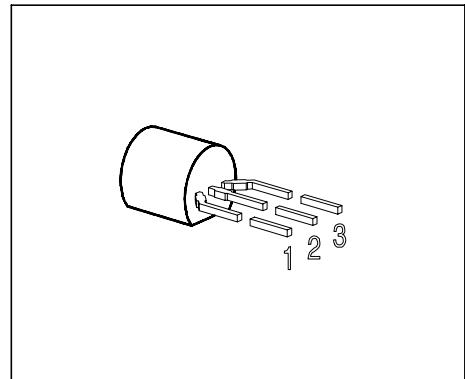


SIPMOS® Small-Signal Transistor

- N channel
- Enhancement mode
- Logic Level
- $V_{GS(th)} = 0.8\ldots 2.0V$



Pin 1	Pin 2	Pin 3
S	G	D

Type	V_{DS}	I_D	$R_{DS(on)}$	Package	Marking
BSS 101	240 V	0.13 A	16 Ω	TO-92	SS 101
Type	Ordering Code		Tape and Reel Information		
BSS 101	Q62702-S493		E6288		
BSS 101	Q62702-S636		E6325		

Maximum Ratings

Parameter	Symbol	Values	Unit
Drain source voltage	V_{DS}	240	V
Drain-gate voltage	V_{DGR}	240	
$R_{GS} = 20 \text{ k}\Omega$			
Gate source voltage	V_{GS}	± 14	
Gate-source peak voltage, aperiodic	V_{gs}	± 20	
Continuous drain current	I_D	0.13	A
$T_A = 33^\circ\text{C}$			
DC drain current, pulsed	I_{Dpuls}	0.52	
$T_A = 25^\circ\text{C}$			
Power dissipation	P_{tot}	0.63	W
$T_A = 25^\circ\text{C}$			

Maximum Ratings

Parameter	Symbol	Values	Unit
Chip or operating temperature	T_j	-55 ... + 150	°C
Storage temperature	T_{stg}	-55 ... + 150	
Thermal resistance, chip to ambient air ¹⁾	R_{thJA}	≤ 200	K/W
DIN humidity category, DIN 40 040		E	
IEC climatic category, DIN IEC 68-1		55 / 150 / 56	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Static Characteristics

Drain- source breakdown voltage $V_{GS} = 0 \text{ V}$, $I_D = 0.25 \text{ mA}$, $T_j = 25^\circ\text{C}$	$V_{(BR)DSS}$	240	-	-	V
Gate threshold voltage $V_{GS}=V_{DS}$, $I_D = 1 \text{ mA}$	$V_{GS(\text{th})}$	0.8	1.4	2	
Zero gate voltage drain current $V_{DS} = 240 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_j = 25^\circ\text{C}$	I_{DSS}	-	0.1	1	μA
$V_{DS} = 240 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_j = 125^\circ\text{C}$		-	2	60	
$V_{DS} = 130 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_j = 25^\circ\text{C}$		-	-	30	nA
Gate-source leakage current $V_{GS} = 20 \text{ V}$, $V_{DS} = 0 \text{ V}$	I_{GSS}	-	1	10	nA
Drain-Source on-state resistance $V_{GS} = 10 \text{ V}$, $I_D = 0.13 \text{ A}$	$R_{DS(\text{on})}$	-	12	16	Ω
$V_{GS} = 4.5 \text{ V}$, $I_D = 0.13 \text{ A}$		-	15	26	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Dynamic Characteristics

Transconductance $V_{DS} \geq 2 * I_D * R_{DS(on)max}$, $I_D = 0.13 \text{ A}$	g_{fs}	0.06	0.16	-	S
Input capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$	C_{iss}	-	60	80	pF
Output capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$	C_{oss}	-	8	12	
Reverse transfer capacitance $V_{GS} = 0 \text{ V}$, $V_{DS} = 25 \text{ V}$, $f = 1 \text{ MHz}$	C_{rss}	-	3.5	5	
Turn-on delay time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 0.26 \text{ A}$ $R_G = 50 \Omega$	$t_{d(on)}$	-	5	8	ns
Rise time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 0.26 \text{ A}$ $R_G = 50 \Omega$	t_r	-	8	12	
Turn-off delay time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 0.26 \text{ A}$ $R_G = 50 \Omega$	$t_{d(off)}$	-	12	16	
Fall time $V_{DD} = 30 \text{ V}$, $V_{GS} = 10 \text{ V}$, $I_D = 0.26 \text{ A}$ $R_G = 50 \Omega$	t_f	-	15	20	

Electrical Characteristics, at $T_j = 25^\circ\text{C}$, unless otherwise specified

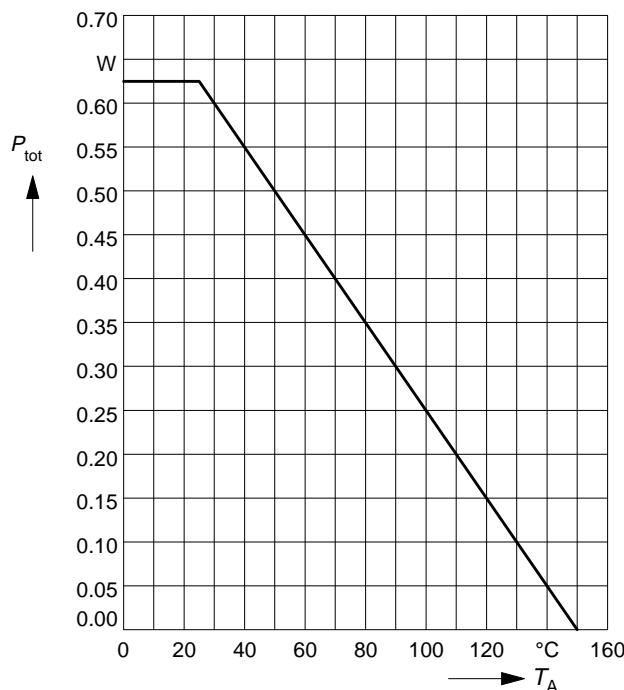
Parameter	Symbol	Values			Unit
		min.	typ.	max.	

Reverse Diode

Inverse diode continuous forward current $T_A = 25^\circ\text{C}$	I_S	-	-	0.13	A
Inverse diode direct current,pulsed $T_A = 25^\circ\text{C}$	I_{SM}	-	-	0.52	
Inverse diode forward voltage $V_{GS} = 0 \text{ V}, I_F = 0.26 \text{ A}$	V_{SD}	-	0.85	1.2	V

Power dissipation

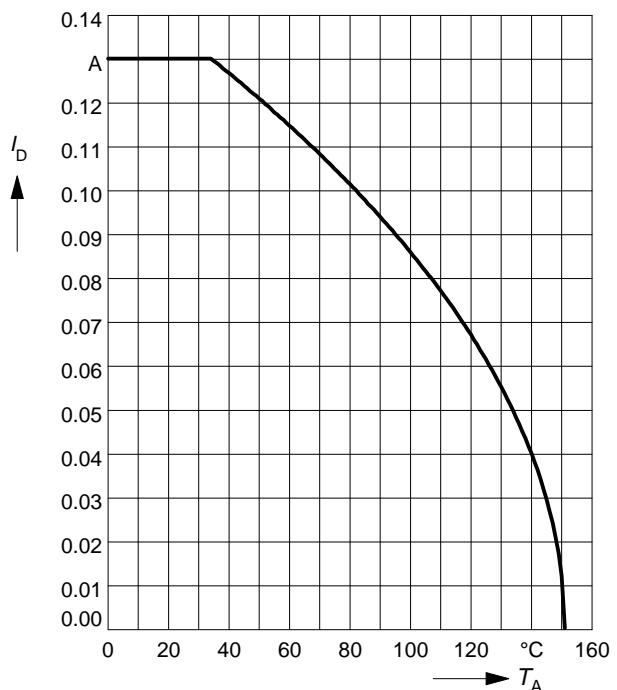
$$P_{\text{tot}} = f(T_A)$$



Drain current

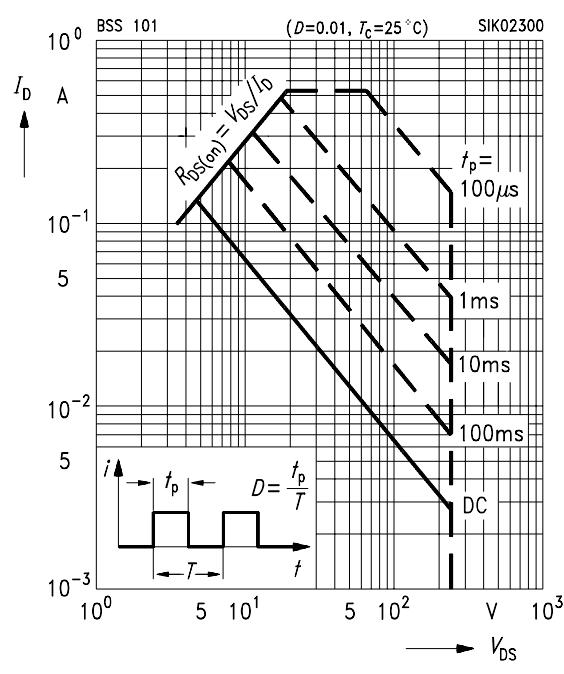
$$I_D = f(T_A)$$

parameter: $V_{GS} \geq 10$ V



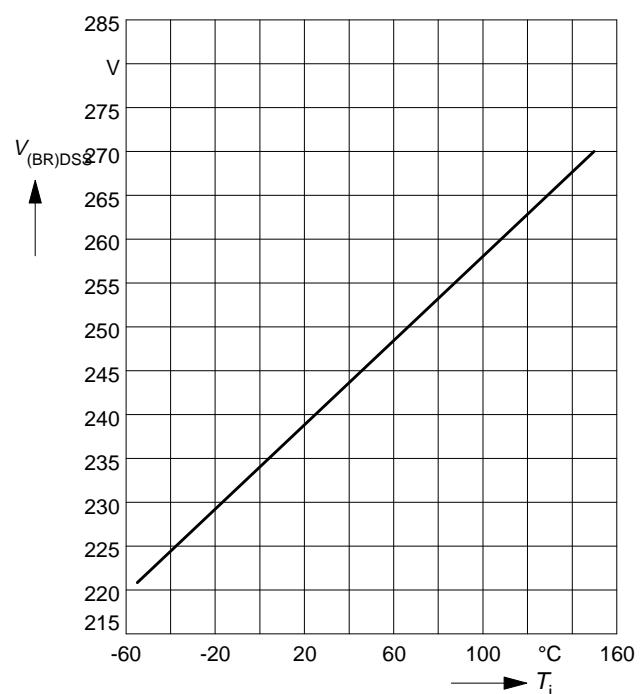
Safe operating area $I_D=f(V_{DS})$

parameter : $D = 0.01$, $T_C=25^\circ\text{C}$



Drain-source breakdown voltage

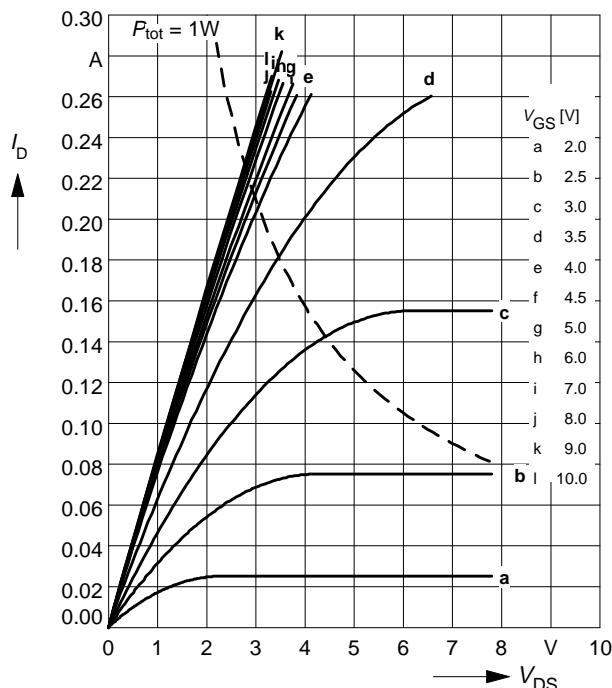
$$V_{(\text{BR})\text{DSS}} = f(T_j)$$



Typ. output characteristics

$$I_D = f(V_{DS})$$

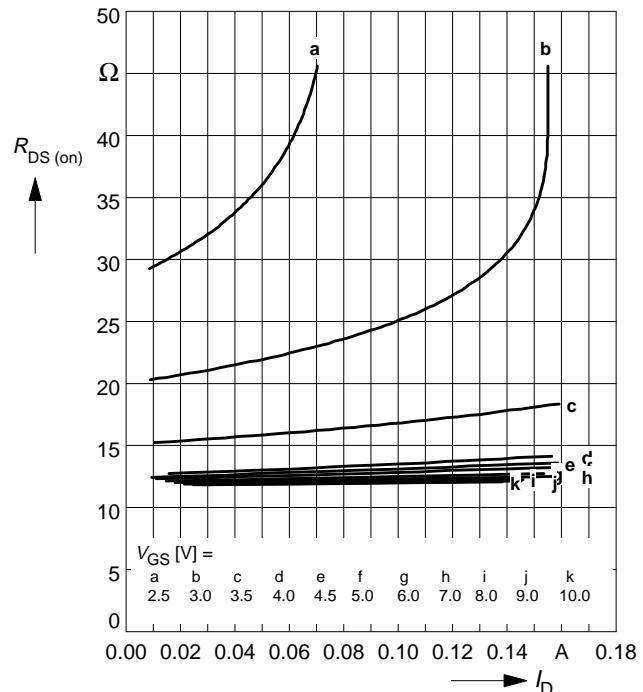
parameter: $t_p = 80 \mu\text{s}$



Typ. drain-source on-resistance

$$R_{DS(on)} = f(I_D)$$

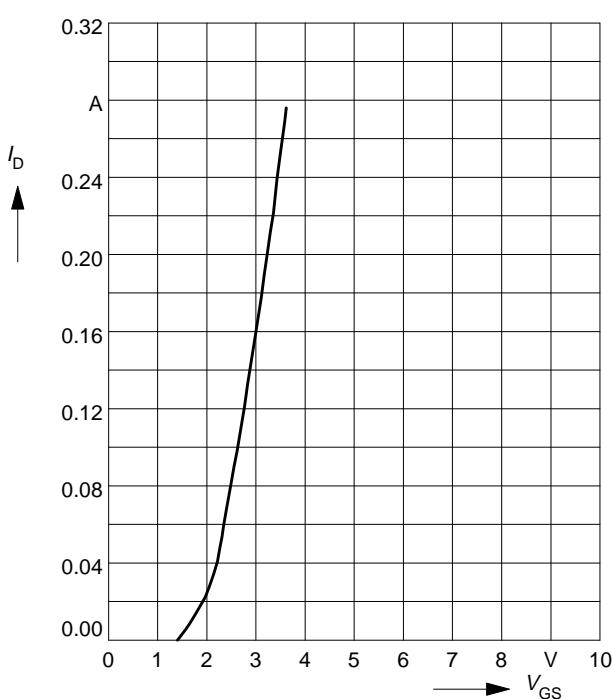
parameter: $t_p = 80 \mu\text{s}, T_j = 25^\circ\text{C}$



Typ. transfer characteristics $I_D = f(V_{GS})$

parameter: $t_p = 80 \mu\text{s}$

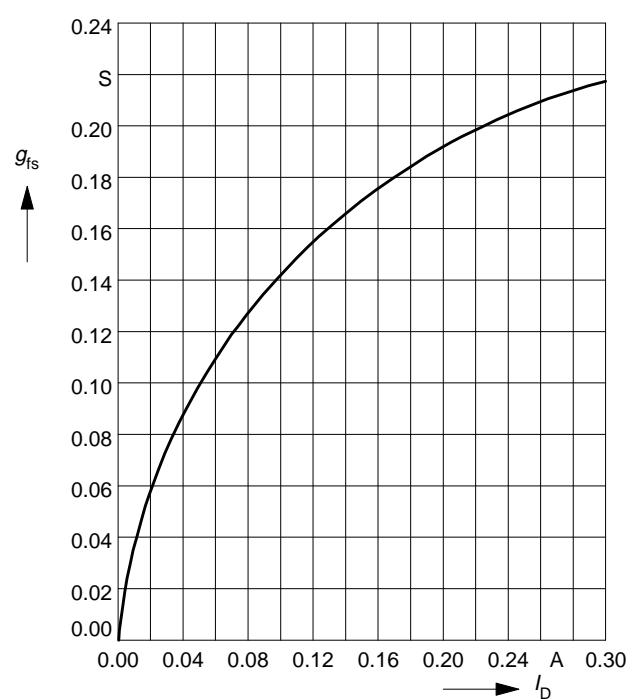
$$V_{DS} \geq 2 \times I_D \times R_{DS(on)\max}$$



Typ. forward transconductance $g_{fs} = f(I_D)$

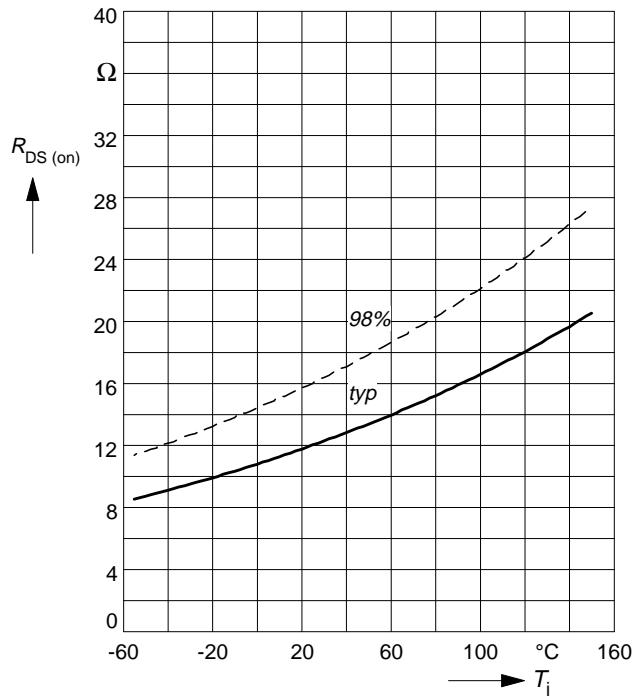
parameter: $t_p = 80 \mu\text{s}$,

$$V_{DS} \geq 2 \times I_D \times R_{DS(on)\max}$$



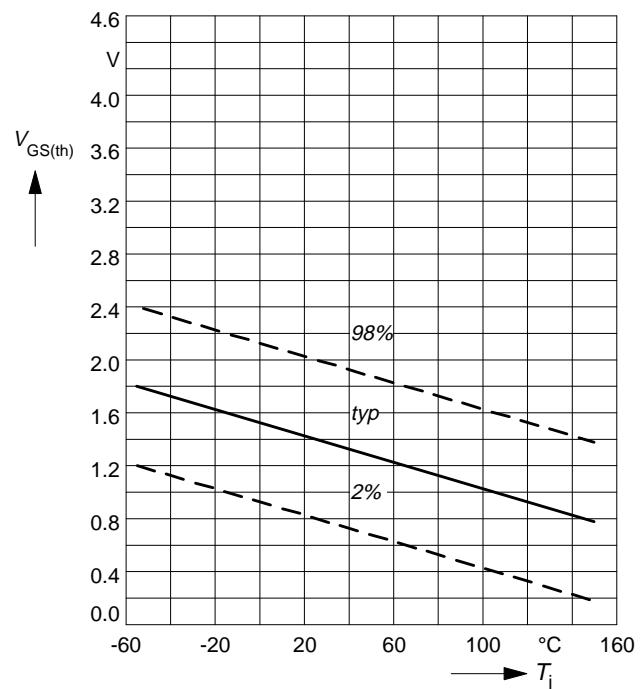
Drain-source on-resistance

$R_{DS(on)} = f(T_j)$
parameter: $I_D = 0.13 \text{ A}$, $V_{GS} = 10 \text{ V}$



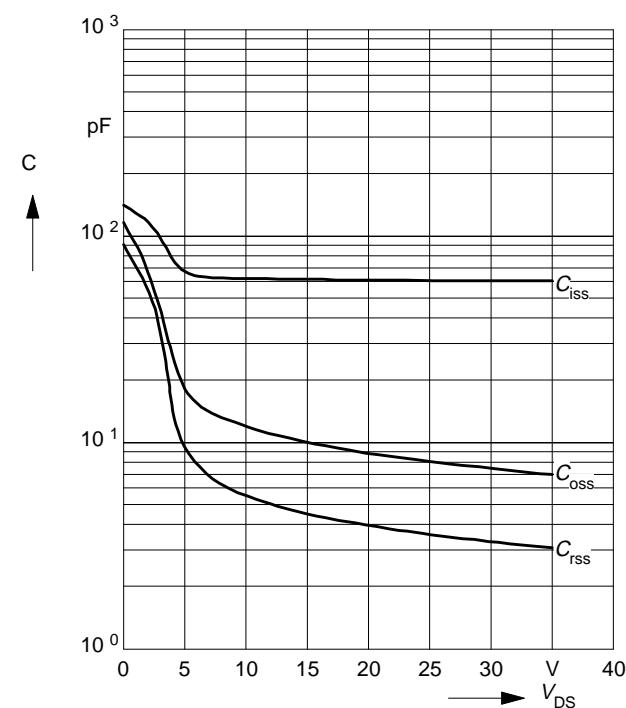
Gate threshold voltage

$V_{GS(th)} = f(T_j)$
parameter: $V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$



Typ. capacitances

$C = f(V_{DS})$
parameter: $V_{GS}=0\text{V}$, $f = 1 \text{ MHz}$



Forward characteristics of reverse diode

$I_F = f(V_{SD})$
parameter: T_j , $t_p = 80 \mu\text{s}$

